# **BUK7508-55A**

# N-channel TrenchMOS standard level FET

Rev. 03 — 14 June 2010

**Product data sheet** 

# 1. Product profile

## 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

## 1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Q101 compliant

- Suitable for standard level gate drive sources
- Suitable for thermally demanding environments due to 175 °C rating

# 1.3 Applications

- 12 V and 24 V loads
- Automotive systems

- General purpose power switching
- Motors, lamps and solenoids

## 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	-	55	V
I <sub>D</sub>	drain current	$V_{GS} = 10 \text{ V}; T_{mb} = 25 \text{ °C};$ see <u>Figure 1</u> ; see <u>Figure 3</u>	[1]	-	-	75	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see Figure 2		-	-	254	W
Static chara	acteristics						
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS}$ = 10 V; $I_D$ = 25 A; $T_j$ = 175 °C; see <u>Figure 11</u> ; see <u>Figure 12</u>		-	-	16	mΩ
		$V_{GS}$ = 10 V; $I_D$ = 25 A; $T_j$ = 25 °C; see <u>Figure 11</u> ; see <u>Figure 12</u>		-	6.8	8	mΩ



Table 1. Quick reference data ...continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Avalanche	ruggedness					
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$\begin{split} I_D &= 75 \text{ A; } V_{sup} \leq 55 \text{ V;} \\ R_{GS} &= 50 \Omega; V_{GS} = 10 \text{ V;} \\ T_{j(init)} &= 25 ^{\circ}\text{C; } unclamped \end{split}$	-	-	670	mJ
Dynamic c	haracteristics					
$Q_{GD}$	gate-drain charge	$V_{GS} = 0 \text{ V; } I_D = 25 \text{ A;}$ $V_{DS} = 44 \text{ V; } T_j = 25 \text{ °C;}$ see Figure 13	-	35	-	nC

<sup>[1]</sup> Continuous current is limited by package.

# 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		2
2	D	drain	mb	D
3	S	source		
mb	D	mounting base; connected to drain	1 2 3	mbb076 S
			SOT78 (TO-220AB)	

# 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK7508-55A	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78

# 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Davamatas						
Parameter	Conditions		Min	Тур	Max	Unit
drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C		-	-	55	V
drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	-	55	V
gate-source voltage			-20	-	20	V
drain current	$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u>	<u>[1]</u>	-	-	126	Α
	$T_{mb} = 100  ^{\circ}\text{C};  V_{GS} = 10  \text{V};  \text{see}  \frac{\text{Figure 1}}{}$	[2]	-	-	75	Α
	$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u>	[2]	-	-	75	Α
peak drain current	$T_{mb}$ = 25 °C; $t_p \le 10 \mu s$ ; pulsed; see <u>Figure 3</u>		-	-	504	Α
total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	-	254	W
storage temperature			-55	-	175	°C
junction temperature			-55	-	175	°C
diode						
source current	T <sub>mb</sub> = 25 °C	[2]	-	-	75	Α
		[1]	-	-	126	Α
peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	-	504	Α
ggedness						
non-repetitive drain-source avalanche energy	$I_D$ = 75 A; $V_{sup}$ ≤ 55 V; $R_{GS}$ = 50 Ω; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; unclamped		-	-	670	mJ
	drain-gate voltage gate-source voltage drain current  peak drain current  total power dissipation storage temperature junction temperature diode source current  peak source current ggedness non-repetitive drain-source avalanche	$ \begin{array}{lll} & \text{drain-gate voltage} & \text{R}_{GS} = 20 \text{ k}\Omega \\ & \text{gate-source voltage} \\ & \text{drain current} & \begin{array}{ll} T_{mb} = 25 \text{ °C; V}_{GS} = 10 \text{ V; see } \underline{\text{Figure 1; see }} \underline{\text{Figure 3}} \\ & T_{mb} = 100 \text{ °C; V}_{GS} = 10 \text{ V; see } \underline{\text{Figure 1}} \underline{\text{Figure 1; see }} \underline{\text{Figure 3}} \\ & \text{peak drain current} & \begin{array}{ll} T_{mb} = 25 \text{ °C; V}_{GS} = 10 \text{ V; see } \underline{\text{Figure 1; see }} \underline{\text{Figure 3}} \\ & \text{peak drain current} & \begin{array}{ll} T_{mb} = 25 \text{ °C; t}_p \leq 10 \text{ µs; pulsed; see } \underline{\text{Figure 2}} \\ & \text{storage temperature} \\ & \text{junction temperature} \\ & \text{junction temperature} \\ & \text{diode} \\ & \text{source current} & \begin{array}{ll} T_{mb} = 25 \text{ °C} \\ & \text{peak source current} \\ & \text{t}_p \leq 10 \text{ µs; pulsed; T}_{mb} = 25 \text{ °C} \\ & \text{ggedness} \\ & \text{non-repetitive} \\ & \text{drain-source avalanche} & \begin{array}{ll} I_D = 75 \text{ A; V}_{\text{sup}} \leq 55 \text{ V; R}_{GS} = 50 \text{ \Omega; } \\ & \text{V}_{GS} = 10 \text{ V; T}_{\text{j(init)}} = 25 \text{ °C; unclamped} \\ \end{array} $	$\begin{array}{lll} & \text{drain-gate voltage} & R_{GS} = 20 \text{ k}\Omega \\ & \text{gate-source voltage} \\ & \text{drain current} & T_{mb} = 25 \text{ °C; V}_{GS} = 10 \text{ V; see } \underline{\text{Figure 1: }} \\ & \text{see } \underline{\text{Figure 3}} \\ & T_{mb} = 100 \text{ °C; V}_{GS} = 10 \text{ V; see } \underline{\text{Figure 1: }} \\ & \text{see } \underline{\text{Figure 3}} \\ & \text{peak drain current} & T_{mb} = 25 \text{ °C; t}_p \leq 10 \text{ µs; pulsed; } \\ & \text{see } \underline{\text{Figure 3}} \\ & \text{total power dissipation} & T_{mb} = 25 \text{ °C; see } \underline{\text{Figure 2}} \\ & \text{storage temperature} \\ & \text{junction temperature} \\ & \text{junction temperature} \\ & \text{diode} \\ & \text{source current} & T_{mb} = 25 \text{ °C} \\ & \text{11} \\ & \text{peak source current} \\ & \text{t}_p \leq 10 \text{ µs; pulsed; T}_{mb} = 25 \text{ °C} \\ & \text{ggedness} \\ & \text{non-repetitive} & I_D = 75 \text{ A; V}_{sup} \leq 55 \text{ V; R}_{GS} = 50 \Omega; \\ & \text{V}_{GS} = 10 \text{ V; T}_{j(init)} = 25 \text{ °C; unclamped} \\ & \text{drain-source avalanche} \\ & In the sum of the sum of$	$\begin{array}{llllllllllllllllllllllllllllllllllll$	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	$\begin{array}{cccccccccccccccccccccccccccccccccccc$

<sup>[1]</sup> Current is limited by power dissipation chip rating.

<sup>[2]</sup> Continuous current is limited by package.

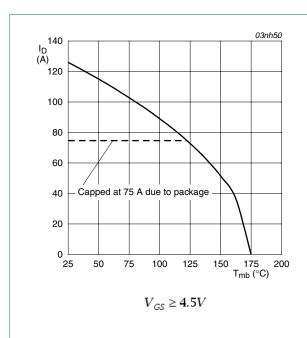


Fig 1. Continuous drain current as a function of mounting base temperature

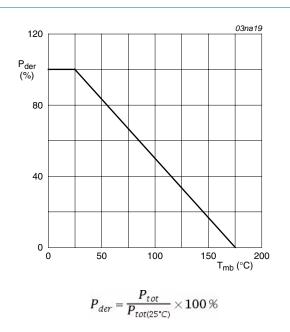
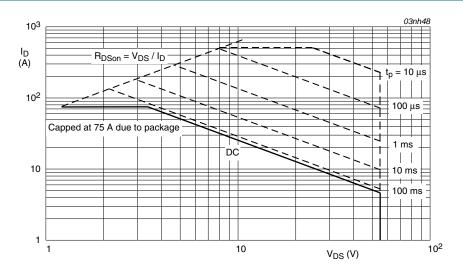


Fig 2. Normalized total power dissipation as a function of mounting base temperature



 $T_{mb} = 25$ °C;  $I_{DM}$ is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

# 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	-	0.59	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	vertical in still air	-	60	-	K/W

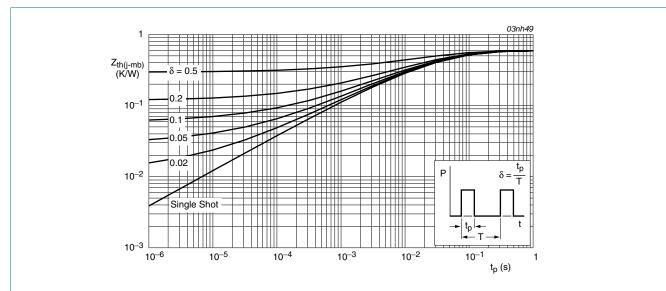


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

# 6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V <sub>(BR)DSS</sub>	drain-source breakdown	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	50	-	-	V
	voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	55	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 175$ °C; see Figure 10	1	-	-	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see Figure 10	2	3	4	V
		$I_D = 1 \text{ mA}$ ; $V_{DS} = V_{GS}$ ; $T_j = -55 \text{ °C}$ ; see Figure 10	-	-	4.4	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μΑ
		$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μΑ
$I_{GSS}$	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 20 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nΑ
		$V_{DS} = 0 \text{ V}; V_{GS} = -20 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	2	100	nΑ
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}$ ; $I_D = 25 \text{ A}$ ; $T_j = 175 \text{ °C}$ ; see <u>Figure 11</u> ; see <u>Figure 12</u>	-	-	16	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 11</u> ; see <u>Figure 12</u>	-	6.8	8	mΩ
Dynamic (	characteristics					
$Q_{G(tot)}$	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 0 \text{ V};$	-	76	-	nC
$Q_{GS}$	gate-source charge	T <sub>j</sub> = 25 °C; see <u>Figure 13</u>	-	16	-	nC
$Q_{GD}$	gate-drain charge		-	35	-	nC
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	3264	4352	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 14</u>	-	719	863	pF
C <sub>rss</sub>	reverse transfer capacitance		-	390	533	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 5 \text{ V};$	-	24	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 10 \Omega; T_j = 25 °C$	-	94	-	ns
$t_{d(off)}$	turn-off delay time		-	100	-	ns
t <sub>f</sub>	fall time		-	80	-	ns
L <sub>D</sub>	internal drain inductance	from contact screw on mounting base to centre ; $T_j = 25  ^{\circ}C$	-	3.5	-	nΗ
		from drain lead 6 mm from package to centre of die ; $T_j = 25$ °C	-	4.5	-	nΗ
L <sub>S</sub>	internal source inductance	from source lead to source bond pad ; $T_j = 25~^{\circ}\text{C}$	-	7.5	-	nΗ
Source-dr	rain diode					
$V_{SD}$	source-drain voltage	$I_S = 25 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; see <u>Figure 15</u>	-	0.85	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 75 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s};$	-	65	-	ns
Q <sub>r</sub>	recovered charge	$V_{GS} = -10 \text{ V}; V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$	-	170	-	nC

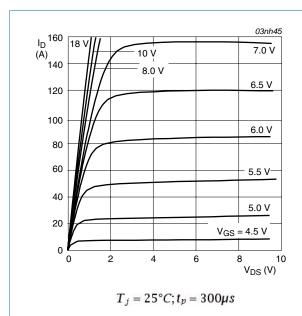


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

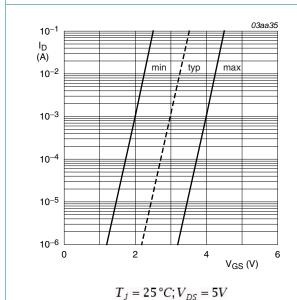


Fig 7. Sub-threshold drain current as a function of gate-source voltage

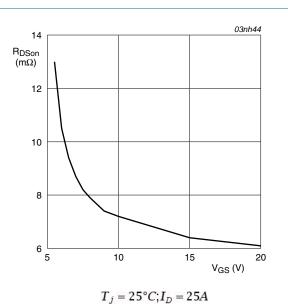


Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values

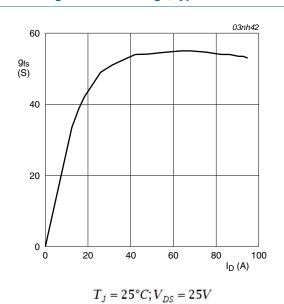


Fig 8. Forward transconductance as a function of drain current; typical values

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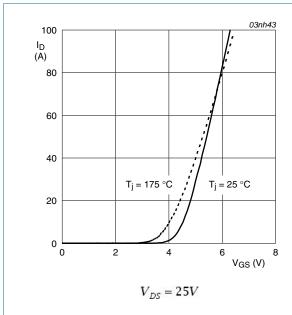


Fig 9. Transfer characteristics: drain current as a function of gate-source voltage; typical values

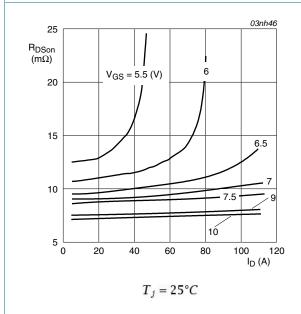
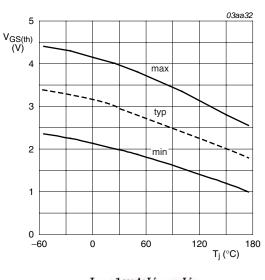


Fig 11. Drain-source on-state resistance as a function of drain current; typical values



 $I_D = 1 mA; V_{DS} = V_{GS}$ 

Fig 10. Gate-source threshold voltage as a function of junction temperature

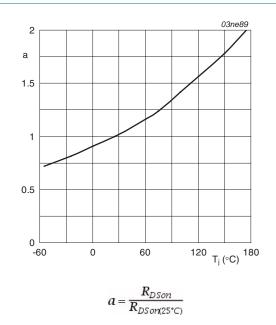


Fig 12. Normalized drain-source on-state resistance factor as a function of junction temperature

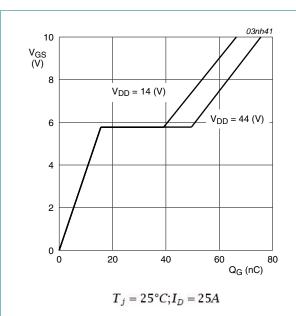
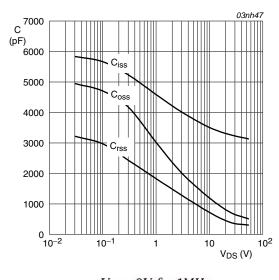


Fig 13. Gate-source voltage as a function of turn-on gate charge; typical values



 $V_{GS} = 0V; f = 1MHz$ 

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

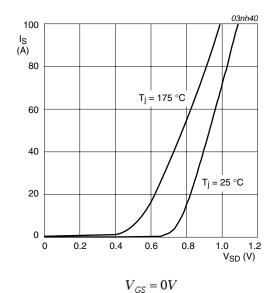
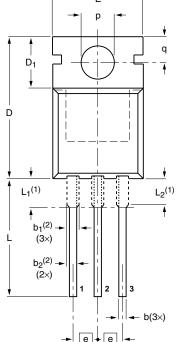


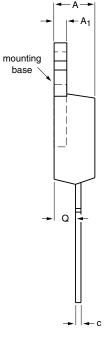
Fig 15. Reverse diode current as a function of reverse diode voltage; typical values

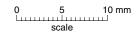
# 7. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78







### **DIMENSIONS** (mm are the original dimensions)

UNIT	Α	A <sub>1</sub>	b	b <sub>1</sub> (2)	b <sub>2</sub> <sup>(2)</sup>	С	D	D <sub>1</sub>	E	е	L	L <sub>1</sub> (1)	L <sub>2</sub> <sup>(1)</sup> max.	р	q	Q
mm	4.7 4.1	1.40 1.25	0.9 0.6	1.6 1.0	1.3 1.0	0.7 0.4	16.0 15.2	6.6 5.9	10.3 9.7	2.54	15.0 12.8	3.30 2.79	3.0	3.8 3.5	3.0 2.7	2.6 2.2

#### Notes

- 1. Lead shoulder designs may vary.
- 2. Dimension includes excess dambar.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA	PROJECTION		
SOT78		3-lead TO-220AB	SC-46		<del>08-04-23</del> 08-06-13	

Fig 16. Package outline SOT78 (TO-220AB)

BUK7508-55A

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# 8. Revision history

## Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes				
BUK7508-55A v.3	20100614	Product data sheet	-	BUK7508_7608_55A v.2				
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>							
	<ul> <li>Legal texts l</li> </ul>	nave been adapted to the r	new company name where	appropriate.				
	<ul> <li>Type number</li> </ul>	er BUK7508-55A separated	I from data sheet BUK7508	3_7608_55A v.2.				
BUK7508_7608_55A v.2	20020117	Product specification	-	-				

# 9. Legal information

#### 9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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# 10. Contact information

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For sales office addresses, please send an email to: <a href="mailto:salesaddresses@nxp.com">salesaddresses@nxp.com</a>

# **BUK7508-55A**

### N-channel TrenchMOS standard level FET

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Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

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